

<b>Notice of References Cited</b>	Application/Control No. 10/615,339	Applicant(s)/Patent Under Reexamination WEISS ET AL.	
	Examiner John T. Kwon	Art Unit 3747	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,041,746	03-2000	Takemura et al.	123/90.16
	B	US-6,041,279	03-2000	Maki et al.	701/104
	C	US-5,996,540	12-1999	Hara, Seinosuke	123/90.16
	D	US-5,632,261	05-1997	Maki et al.	123/674
	E	US-5,460,130	10-1995	Fukuzawa et al.	123/90.16
	F	US-5,263,441	11-1993	Rembold et al.	123/90.12
	G	US-5,209,201	05-1993	Horie et al.	123/308
	H	US-5,103,792	04-1992	Winkler et al.	123/506
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.